

SE556, SE556C, SA556, NE556 DUAL PRECISION TIMERS

D2440, APRIL 1978—REVISED OCTOBER 1988

- Two Precision Timing Circuits per Package
- Astable or Monostable Operation
- TTL-Compatible Output Can Sink or Source Up to 150 mA
- Active Pull-Up or Pull-Down
- Designed to be Interchangeable with Signetics SE556, SE556C, SA556, NE556

APPLICATIONS

Precision Timer from Microseconds to Hours	Sequential Timer Pulse Generator
Pulse-Shaping Circuit	Time-Delay Circuit
Missing-Pulse Detector	Frequency Divider
Tone-Burst Generator	Appliance Timer
Pulse-Width Modulator	Industrial Controls
Pulse-Position Modulator	Touch-Tone Encoder

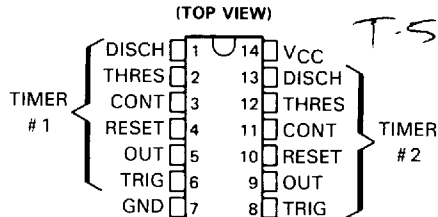
**SE556C FROM TI IS NOT
RECOMMENDED FOR NEW DESIGNS**

description

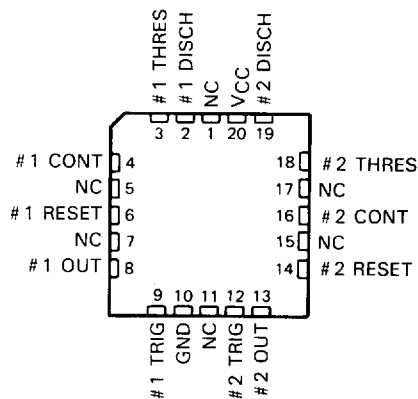
These devices provide two monolithic, independent timing circuits of the SE555, SE555C, SA555, or NE555 type in each package. These circuits can be operated in the astable or the monostable mode with external resistor-capacitor timing control. The basic timing provided by the RC time constant may be actively controlled by modulating the bias of the control voltage input.

The threshold and trigger levels are normally two-thirds and one-third respectively of V_{CC} . These levels can be altered by use of the control voltage terminal. When the trigger input falls below trigger level, the flip-flop is set and the output goes high. If the trigger input is above the trigger level and the threshold input is above the threshold level, the flip-flop is reset and the output is low. The reset input can override all other inputs and can be used to initiate a new timing cycle. When the reset input goes low, the flip-flop is reset and the output goes low. Whenever the output is low, a low impedance path is provided between the discharge terminal and ground.

SE556, SE556C . . . J PACKAGE
SA556, NE556 . . . D, J, OR N PACKAGE

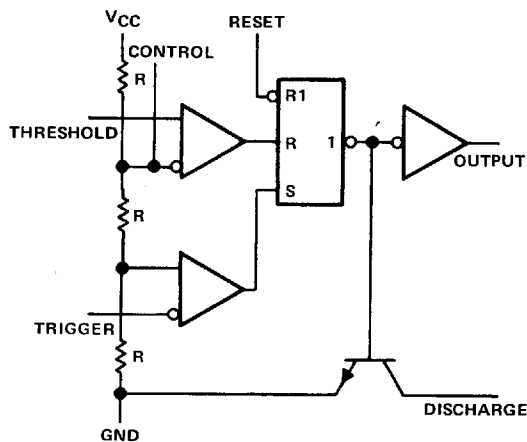


SE556, SE556C . . . FK PACKAGE
(TOP VIEW)



NC—No internal connection

functional block diagram (each timer)



Reset can override Trigger, which can override Threshold.

PRODUCTION DATA documents contain information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS
INSTRUMENTS**

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T-51-19

The SE556 and SE556C are characterized for operation over the full military range of -55°C to 125°C . The SA556 is characterized for operation from -40°C to 85°C , and the NE556 is characterized for operation from 0°C to 70°C .

AVAILABLE OPTIONS

T _A RANGE	V _{thres} MAX V _{CC} = 15 V	PACKAGE			
		SMALL OUTLINE (D)	CHIP CARRIER (FK)	CERAMIC DIP (J)	PLASTIC DIP (N)
0°C to 70°C	11.2 V	NE556D		NE556J	NE556N
-40°C to 85°C	11.2 V	SA556D		SA556J	SA556N
-55°C to 125°C	10.6 V 11.2 V		SE556FK SE556CFK	SE556J SE556CJ	

The D package is available taped and reeled. Add the suffix R to the device type (e.g., NE556DR).

FUNCTION TABLE

RESET	TRIGGER VOLTAGE†	THRESHOLD VOLTAGE†	OUTPUT	DISCHARGE SWITCH
Low	Irrelevant	Irrelevant	Low	On
High	< 1/3 V _{DD}	Irrelevant	High	Off
High	> 1/3 V _{DD}	> 2/3 V _{DD}	Low	On
High	> 1/3 V _{DD}	< 2/3 V _{DD}	As previously established	

†Voltage levels shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC} (See Note 1)	18 V
Input voltage (control, reset, threshold, and trigger)	V _{CC}
Output current	± 225 mA
Continuous total dissipation	see Dissipation Rating Table
Operating free-air temperature range: SE556, SE556C	-55°C to 125°C
SA556	-40°C to 85°C
NE556	0°C to 70°C
Storage temperature range	-65°C to 150°C
Case temperature for 60 seconds: FK package	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: J package	300°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D or N package	260°C

NOTE 1: All voltage values are with respect to network ground terminal.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤ 25°C	DERATING	T _A = 70°C	T _A = 85°C	T _A = 125°C
	POWER RATING	FACTOR ABOVE T _A = 25°C	POWER RATING	POWER RATING	POWER RATING
D	950 mW	7.6 mW/°C	608 mW	494 mW	N/A
FK	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
J (SE556, SE556C)	1375 mW	11.0 mW/°C	880 mW	715 mW	275 mW
J (SA556, NE556)	1025 mW	8.2 mW/°C	656 mW	533 mW	N/A
N	1575 mW	12.6 mW/°C	1008 mW	819 mW	N/A



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recommended operating conditions

	SE556		SE556C		SA556		NE556		UNIT
	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
Supply voltage, V_{CC}	4.5	18	4.5	16	4.5	16	4.5	16	V
Input voltage (control, reset, threshold, and trigger)	V_{CC}		V_{CC}		V_{CC}		V_{CC}		V
Output current	± 200		± 200		± 200		± 200		mA
Operating free-air temperature, T_A	-55	125	-55	125	-40	85	0	70	$^{\circ}\text{C}$

electrical characteristics at 25 $^{\circ}\text{C}$ free-air temperature, $V_{CC} = 5\text{ V}$ to 15 V (unless otherwise noted)

PARAMETER	TEST CONDITIONS	SE556			SE556C, SA556, NE556			UNIT	
		MIN	TYP	MAX	MIN	TYP	MAX		
Threshold voltage level	$V_{CC} = 15\text{ V}$	9.4	10	10.6	8.8	10	11.2	V	
	$V_{CC} = 5\text{ V}$	2.7	3.3	4	2.4	3.3	4.2		
Threshold current (see Note 2)			30	250		30	250	nA	
Trigger voltage level	$V_{CC} = 15\text{ V}$	4.8	5	5.2	4.5	5	5.6	V	
	$V_{CC} = 5\text{ V}$	1.45	1.67	1.9	1.1	1.67	2.2		
Trigger current	Trigger at 0 V		0.5	0.9		0.5	2	μA	
Reset voltage level		0.3	0.7	1	0.3	0.7	1	V	
Reset current	Reset at V_{CC}		0.1	0.4		0.1	0.4	mA	
	Reset at 0 V		-0.4	-1		-0.4	-1.5		
Discharge switch off-state current			20	100		20	100	nA	
Control voltage (open circuit)	$V_{CC} = 15\text{ V}$	9.6	10	10.4	9	10	11	V	
	$V_{CC} = 5\text{ V}$	2.9	3.3	3.8	2.6	3.3	4		
Low-level output voltage	$V_{CC} = 15\text{ V}$	$I_{OL} = 10\text{ mA}$		0.1	0.15		0.1	0.25	V
		$I_{OL} = 50\text{ mA}$		0.4	0.5		0.4	0.75	
		$I_{OL} = 100\text{ mA}$		2	2.2		2	2.5	
	$V_{CC} = 5\text{ V}$	$I_{OL} = 200\text{ mA}$		2.5		2.5			
		$I_{OL} = 5\text{ mA}$		0.1	0.15		0.1	0.25	
		$I_{OL} = 8\text{ mA}$		0.15	0.25		0.15	0.3	
High-level output voltage	$V_{CC} = 15\text{ V}$	$I_{OH} = -100\text{ mA}$	13	13.3		12.75	13.3	V	
		$I_{OH} = -200\text{ mA}$		12.5		12.5			
	$V_{CC} = 5\text{ V}$	$I_{OH} = -100\text{ mA}$	3	3.3		2.75	3.3		
Supply current	Output low, No load	$V_{CC} = 15\text{ V}$		20	24		20	30	mA
		$V_{CC} = 5\text{ V}$		6	10		6	12	
	Output high, No load	$V_{CC} = 15\text{ V}$		18	20		18	26	
		$V_{CC} = 5\text{ V}$		4	8		4	10	

NOTE 2: This parameter influences the maximum value of the timing resistors R_A and R_B in the circuit of Figure 1. For example, when $V_{CC} = 5\text{ V}$, the maximum value is $R = R_A + R_B \approx 3.4\text{ M}\Omega$, and for $V_{CC} = 15\text{ V}$, the maximum value is $\approx 10\text{ M}\Omega$.

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operating characteristics, $V_{CC} = 5\text{ V}$ and 15 V

PARAMETER		TEST CONDITIONS†	SE556			SE556C, SA556, NE556			UNIT
			MIN	TYP	MAX	MIN	TYP	MAX	
Initial error of timing interval‡	Each timer, monostable§	$T_A = 25^\circ\text{C}$	0.5		1.5	1		3	%
	Each timer, astable¶		1.5		2.25				
	Timer 1 – Timer 2		± 0.5		± 1				
Temperature coefficient of timing interval	Each timer, monostable§	$T_A = \text{MIN to MAX}$	30	100	50				ppm/°C
	Each timer, astable¶		90		150				
	Timer 1 – Timer 2		± 10		± 10				
Supply voltage sensitivity of timing interval	Each timer, monostable§	$T_A = 25^\circ\text{C}$	0.05	0.2	0.1	0.5			%/V
	Each timer, astable¶		0.15		0.3				
	Timer 1 – Timer 2		± 0.1		± 0.2				
Output pulse rise time		$C_L = 15\text{ pF}$	100	200	100	300			ns
Output pulse fall time		$T_A = 25^\circ\text{C}$	100	200	100	300			

†For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡Timing interval error is defined as the difference between the measured value and the average value of a random sample from each process run.

§Values specified are for a device in a monostable circuit similar to Figure 2, with component values as follow: $R_A = 2\text{ k}\Omega$ to $100\text{ k}\Omega$, $C = 0.1\text{ }\mu\text{F}$.

¶Values specified are for a device in an astable circuit similar to Figure 1, with component values as follow: $R_A = 1\text{ k}\Omega$ to $100\text{ k}\Omega$, $C = 0.1\text{ }\mu\text{F}$.

TYPICAL APPLICATION DATA

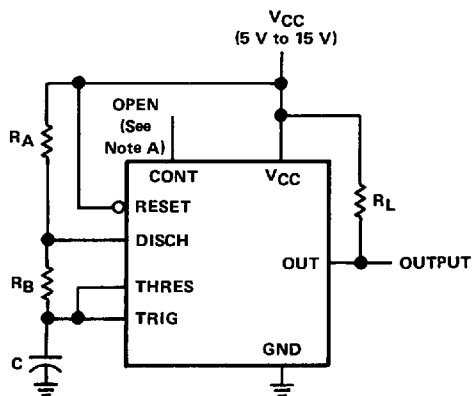


FIGURE 1. CIRCUIT FOR ASTABLE OPERATION

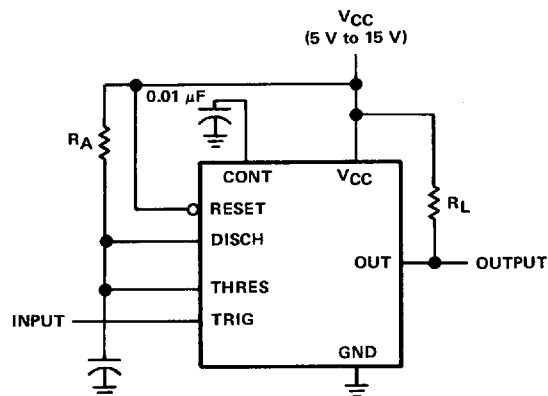


FIGURE 2. CIRCUIT FOR MONOSTABLE OPERATION

NOTE A: Bypassing the control voltage input to ground with a capacitor may improve operation. This should be evaluated for individual applications.

